

<b>Notice of References Cited</b>	Application/Control No. 10/025,037	Applicant(s)/Patent Under Reexamination HEVEY, MAURICE O.	
	Examiner Susan T. Tran	Art Unit 1615	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,925,669	07-1999	Katz et al.	514/449
	B	US-6,267,985	07-2001	Chen et al.	424/451
	C	US-2003/0215547	11-2003	Leyh, Joseph Conrad JR.	426/98
	D	US-2004/0109853	06-2004	McDaniel, C. Steven	424/094.6
	E	US-2005/0089550	04-2005	Rosenberg et al.	424/442
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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